The Recurrent Event Process of a Success Preceded by a Failure and its Application

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Abstract. We describe a simple discrete time renewal process of an event where a success is preceded by a failure. Its properties, especially the distributions of the counting and the interval processes, are investigated. We also propose an application to statistical process control based on the waiting time between two adjacent events. It is shown that the average number inspected under the new control scheme is larger than with the so called *CCC* control chart.

Keywords: Average Number Inspected, Bernoulli Trials, Counting Process, Quality Control, Recurrent Event Process, Waiting Time.

1. Introduction

Suppose we have a sequence of independent Bernoulli trials with outcomes of success (S) or failure (F). Many recurrent events can be generated by the Bernoulli trials (Feller, Chapter XIII, 1968). For example, one may be interested in the recurrent events of having runs of S of length k. In fact, there are various ways of counting the number of runs of S of length k (see, for example, Wang and Ji, 1995). Here, we consider an interesting event derived from the Bernoulli sequence and defined by

$$E = \{A \text{ sucess preceded by one or more failures} \}.$$

The event E is somewhat reminiscent of an old popular Chinese saying "Failure is the mother of success". Effectively, it means a success will arrive after a cumulative number of failures. Of course, this saying has a connotation of 'cause and effect'; however, the E defined here only describes a phenomenon since the trials are assumed to be independent.

Consider an automated production process of items in which an item may be classified as either conforming F or nonconforming S. Each individual item is inspected in the order of production. If this is not a 100% inspection scheme, a sampling device will be used for selecting an item. Then the event E defined above corresponds to the appearance of the first nonconforming after one or more conforming items have been inspected. This event may be slightly reworded as

$$E = \{ Appearance of the doublet FS \}$$

Consider a familiar experiment of coin tossings in which we designate S = H, F = T having p = q = 1/2. Then the event E may also constitute a betting game for a player

who selects E against another player whose betting strategy is to obtain a HH first, for example.

This recurrent event process may be considered as a special case of a more general 'pattern in Bernoulli trials' studied in Hunter (1983, pp. 118-120).

The first part of the paper is devoted to the study of the counting process $\{N_n\}$ and the interval process $\{S_k\}$, $k \ge 1$. Since most of the properties can be obtained through using some standard theory, we therefore omit many of the details. Instead, we approach our analyses from some intuitive first principles that are often more interesting and reveal more about the process than that from the probability generating functions.

The main thrust of the paper is to demonstrate how the waiting time between two consecutive occurrences of E may be used for constructing a control chart in quality control. It is found that this new control scheme for fraction nonconforming has a larger 'average number inspected' than a more established chart known as the CCC control chart when the production process is in control.

2. Distribution of Waiting Time Between Two Consecutive Recurrent Events

Let T be the time from the origin to the first occurrence of E. In other words, T represents the waiting time for the first appearance of FS. This is also the waiting time between the occurrences of two consecutive E's. Then T = n if the following sequence occurs:

Let

$$f_n = P\big\{T = n\big\}.$$

Clearly, $f_1 = 0$. The probability sequence $\{f_n\}$ may be obtained as in Hombas (1997) who partitioned the sample space into sets that begin with F and S. However, this approach is cumbersome as can be seen in Hombas' paper. Other methods may be used to derive f_n , see for example, Chapter 3 of Hunter (1983). Here, we shall describe a more direct approach as follows:

First, T = n means that the event E occurs at $n, n \ge 2$, for the first time. This is equivalent to having observed a sequence that begins with iS's, $0 \le i \le n - 2$, followed by (n-1-i)F's and then by S at n. In other words, E occurs at n if the outcome of the nth trial is the first S that is preceded by one or more failures.

It is now obvious that the distribution of T is given by

$$f_{n} = \sum_{i=0}^{n-2} p^{i} q^{n-1-i} p$$

$$= pq^{n-1} \sum_{i=0}^{n-2} \left(\frac{p}{q}\right)^{i}$$

$$= \begin{cases} \frac{pq^{n} - qp^{n}}{q - p}, p \neq q, n \geq 2, \\ (n-1)\frac{1}{2^{n}}, p = q, n \geq 2. \end{cases}$$
(2.1)

We will soon see that (2.1) may be derived by another easy but well established method.

It is straight forward to verify that $\sum_{i=2}^{\infty} f_i = 1$; so E is indeed a persistent recurrent process (pp. 75, Hunter, 1983).

Now the probability generating function (p.g.f.) F(s) of the sequence $\{f_n\}$ is given by

$$F(s) = \frac{pqs^2}{pqs^2 - s + 1}. (2.2)$$

Next, define

$$u_n = P\{E \text{ occurs at the } n^{th} \text{ trial}\}, u_0 = 1.$$
 (2.3)

As E occurs at n (not necessary for the first time) if and only if the outcomes at the (n-1)th and the nth trial are F and S, respectively, it is obvious that

$$u_0 = 1, u_1 = 0, u_2 = u_3 = \dots = pq.$$
 (2.4)

From (2.4), we would be able to find the distribution of T, *i.e.*, the sequence $\{f_n\}$, through the well known relationship between the generating function (g.f.) of $\{u_n\}$ and the p.g.f. F(s). However, we omit the details here and refer the readers to Chapter 3 of Hunter (1983).

2.1. Mean Recurrence Time and Variance

We now proceed to find the first two moments of the waiting time random variable T. First, the mean recurrence time of E, i.e., E(T), may be obtained from (2.2) by differentiating F(s) with respect to s giving

$$\mu = E(T) = F'(1) = \frac{1}{pq}.$$
 (2.5)

As was observed earlier, E is persistent. Clearly it is also aperiodic; so $\mu = \frac{1}{\mu_{\infty}} = \frac{1}{pq}$ (Hunter, 1983, pp 119).

In contrast, the mean waiting time of the event $\{SS\}$ (i.e. mean recurrence time of a success run of length 2) is given by (Feller, 1968, pp. 324)

$$\mu_s = \frac{1+p}{p^2}. (2.6)$$

When p = q = .5, it is easy to see from (2.5)-(2.6) that the mean waiting time for $\{FS\}$ is 4 and 6 for $\{SS\}$, respectively. This fact was noted in Hombas (1997). The question arises: For what value of p would the above two events end up with the same mean waiting

time? Setting $\frac{1+p}{p^2} = \frac{1}{pq}$ and solve for p, we get p = .6181. In other words, if two

players A and B are tossing a biased coin with probability of getting an H (i.e S) being .6181 and that A bets for FS and B for SS, respectively, then the expected waiting time would be the same for both players.

Now the outcome SS is always preceded by FS except when SS appears on the first two trials. Therefore the probability that FS will beat SS, *i.e.*, the probability that FS will appear before SS does in a sequence of independent trials, is $1 - p^2$. When p = .6181, $1 - p^2 = p = .6181$ which is greater than .5. In other words, at the value p = .6181, it is more likely that FS will appear earlier than SS although their mean waiting times are identical.

The variance of T is given by

$$Var(T) = \sigma^2 = \frac{1 - 3pq}{p^2 q^2}.$$
 (2.7)

It is apparent from (2.7) that Var(T) is minimum when p = q = 0.5.

3. Distribution of S_k

Let S_k denote the number of Bernoulli trials required to obtain the k^{th} E and N_n , the number of occurrences of E up to and including the n^{th} trial. The two variables are related by

$$P\{N_n = k\} = P\{S_k \le n\} - P\{S_{k+1} \le n\}. \tag{3.1}$$

We may represent the partial sum as:

$$S_n = T_1 + T_2 + \dots T_n ,$$

where T_i denotes the number of Bernoulli trials we observe between the $(i-1)^{th}$ and the i^{th} occurrence of FS, including the last trial that completes the pattern E. Note in particular, $T_1 = T$.

Clearly, the sequence $\{T_i\}$ consists of independent random variables. It now follows from (2.2) together with independence of the members of $\{T_i\}$, that the p.g.f. of S_k is simply given by

$$P_k(s) = \left\{ \frac{pqs^2}{(1 - ps)(1 - qs)} \right\}^k. \tag{3.2}$$

For k = 2 and k = 3, we can show by using partial fractions and extracting the coefficient of s^n that:

$$P\left\{S_2 = n\right\} = \frac{1}{(q-p)^2} \left\{ (n-3)p^2q^n + (n-3)q^2p^n + \frac{2q^3p^n}{q-p} - \frac{2p^3q^n}{q-p} \right\}, \ n \ge 4 \tag{3.3}$$

and

$$P\left\{S_{3}=n\right\} = \frac{p^{3}q^{3}}{(q-p)^{3}} \left\{ \left[\binom{n-4}{2} + \frac{6p^{2}}{(q-p)^{2}} \right] q^{n-3} - \left[\binom{n-4}{2} + \frac{6q^{2}}{(q-p)^{2}} \right] p^{n-3} - \frac{3pq(n-5)}{q-p} (q^{n-4} + p^{n-4}) \right\}, \qquad n \ge 6$$

$$(3.4)$$

It was pointed out by one of the referees that in general, we have

$$P\{S_k = n\} = \sum_{i=0}^{n-2k} {k+i-1 \choose i} {n-k-i-1 \choose n-2k-i} p^{i+k} q^{n-k-i}$$
(3.5)

for n = 2k, 2k + 1,

A closed form expression from this formula does not appear to be possible.

4. The Number of Occurrences of E, N_n

Let N_n be the number of recurrent events E that occur up to and including the n^{th} trial (excluding the occurrence of E at the 0^{th} trial). We now focus our attention to the study of the counting process N_n that is associated with E.

Recall, (3.1) provides a key link between S_k and N_n , that is:

$$P\big\{N_n=k\big\}=P\big\{S_k\leq n\big\}-P\big\{S_{k+1}\leq n\big\}\,.$$

In particular,

$$P\{N_n = 0\} = 1 - P\{S_1 \le n\} = P\{T > n\}$$

$$= \frac{q^{n+1} - p^{n+1}}{q - p}.$$
(4.1)

Next, $P\{N_n = 1\}$ and $P\{N_n = 2\}$ may be evaluated through equations (3.3-(3.4). However, we opt to use the following more intuitive and direct approach:

$$P\{N_n = 1\} = \sum_{i=2}^{n} P\{E \text{ occurs at } i \text{ for the first time and } N_{n-i} = 0\}$$

$$= \frac{1}{(q-p)^2} \left\{ (n-1) \left(pq^{n+1} + qp^{n+1} \right) + 2 \times \frac{(pq)^2 (p^{n-1} - q^{n-1})}{(q-p)} \right\}$$
(4.2)

and

$$P\{N_{n} = 2\}$$

$$= \frac{1}{(q-p)^{3}} \left\{ \frac{1}{2} (n-3)(n-2)(p^{2}q^{n+1} - q^{2}p^{n+1}) - (n-2)(p^{3}q^{n} - q^{3}p^{n}) \right\}$$

$$+ \frac{(pq)^{3}}{(q-p)^{5}} \left\{ q^{n-1} - p^{n-1} - (n-2)(q^{2}p^{n-3} - q^{n-3}p^{2}) + (n-3)(qp^{n-2} - pq^{n-2}) \right\}$$

$$+ \frac{2p^{2}q^{2}}{(q-p)^{4}} \left\{ -(n-3)\left[qp^{n-1} + pq^{n-1}\right] + \frac{2p^{2}q^{2}(q^{n-3} - p^{n-3})}{q-p} \right\}.$$
(4.3)

We may continue iteratively, yielding

$$P\{N_n = k\} = \sum_{i=2}^{n-(2k-2)} f_i P\{N_{n-i} = k-1\}, n \ge 2k.$$
(4.5)

A more explicit expression for the distribution of N_n can be derived simply by using Cor 3.4.4A of Hunter (1983) which states that

$$\sum_{n=0}^{\infty} P\{N_n = k\} s^n = \frac{[1 - F(s)]F(s)^k}{1 - s} = \frac{(pqs^2)^k}{[(1 - ps)(1 - qs)]^{k+1}}.$$

By expanding the above expression into a product of two polynomials in s and then extracting the coefficient of s^n , we have

$$P\{N_n = k\} = \sum_{i=0}^{n-2k} {k+i \choose i} {n-k-i \choose n-2k-i} p^{k+i} q^{n-k-i}, n \ge 2k .$$
 (4.6)

A closed form expression for general *k* from this expression is unknown.

For many practical purposes, we may only need to know about the first two moments of N_n .

It follows from (3.4.9) of Hinter (1983) and our (2.4) above that the mean count of E's in (0, n] is given by

$$EN_n = \sum_{k=1}^n u_k = (n-1)pq. (4.7)$$

To find the variance of N_n , we may use (2.4), (4.7) and the following identify that holds for any recurrent event process:

$$E(N_n^2) = u_1 + u_2 + \dots + u_n + 2\sum_{j=1}^{n-1} u_j (u_1 + \dots + u_{n-j}).$$
(4.8)

Without having to rely on the theory of recurrent event process, we now proceed to derive the mean and variance from the first principles. These are more interesting and reveal more about the process than that from the p.g.f. F(s).

Consider the sequence of independent Bernoulli trials beginning from i = 1 till i = n. At each $i, i \ge 2$, an event E either occurs with probability p' = pq or E does not occur with probability q' = 1 - p' = 1 - pq. Form an associated sequence of binary variables denoted by $\{Y_i\}$, $i \ge 2$ such that

$$P\{Y_i = 1\} = pq, P\{Y_i = 0\} = 1 - pq.$$
(4.9)

The counting process $\{N_n\}$ may now be expressed in terms of $\{Y_i\}$:

$$N_n = Y_2 + Y_3 + \dots Y_n , (4.10)$$

and hence

$$EN_n = \sum_{i=2}^n \text{Expected Number of } E' \text{s at Trial No.} i$$

$$= \sum_{i=2}^n E(Y_i) = (n-1)pq. \tag{4.11}$$

Unlike the original Bernoulli sequence, $\{Y_i\}$, $i \ge 2$, is not sequence of independent random variables although Y_i and Y_{i+k} are independent for $k \ge 2$. Hence,

$$Var\{N_n\} = Var\{Y_2 + Y_3 + ... Y_n\}$$

$$= \sum_{i=2}^{n} Var\{Y_i\} + 2\sum_{j>i=2}^{n} Cov\{Y_i, Y_j\}$$

$$= (n-1)pq(1-pq) + 2(n-2) \times Cov\{Y_i, Y_{i+1}\}$$

$$= (n-1)pq(1-pq) - 2(n-2)(pq)^2$$

$$= (n-1)pq - (3n-5)(pq)$$
(4.12)

The ratio of variance to mean is

$$\frac{Var\{N_n\}}{EN_n} = 1 - \frac{(3n-5)pq}{(n-1)}.$$
(4.13)

Now

$$\frac{(3n-5)pq}{(n-1)} \le 3pq \le \frac{3}{4} \text{ which implies } \frac{1}{4} \le \frac{Var\{N_n\}}{EN_n} \le \frac{3}{4},$$

so that there is an apparent under dispersion for this process relative to the Poisson process.

5. A Control Chart to be Based on *T*

Production processes are usually of very high quality today. Particularly, in an electronic industry such as integrated circuits manufacturing, the fraction nonconforming p is in the parts-per-million (PPM) range such as 0.0001 or 100PPM. The standard Statistical Process Control (SPC) techniques are not very suitable for near zero-defect environment as detailed by Goh (1987). The main problem is: there are too many false alarms, and it is impossible to detect process improvement, as the lower control limit (LCL) for a p or np-chart will not exist. In what follows, we assume that p < q. This is necessary for any production process. In fact, we may simply assume that p < 0.1 whenever applicable.

5.1 Cumulative Count of Conforming (CCC) Control Chart

A useful control procedure for such a high-quality process is based on the statistic Y, the number of conforming units between two successive occurrences of nonconforming items. The statistic Y is designated as the Cumulative Count of Conforming (CCC) units by Goh (1987), see also Lucas (1989), Xie and Goh (1992). Some other discussions on a decision procedure based on Y can be seen in Nelson (1994) and Quesenberry (1995).

Let $E_0 = \{ \text{Occurence of an } S \}$ where S here denotes the outcome of the inspected unit being nonconforming. It is clear that such a continuous sampling procedure may be regarded as a recurrent event process. However, it is necessary to clarify our notation here. In the references just cited above, Y denotes the number of conforming units between two nonconforming units. In contrast, the waiting time between the two consecutive occurrences of an event in the recurrent event theory traditionally includes the trial that 'completes' the event. In other words, Y+1 is the waiting time instead of Y. For consistency, we let $T_0 = Y+1$.

It should be noted that the cumulative count of conforming (CCC) control chart is useful for monitoring a high-quality process. It is equally effective for controlling other processes that have a moderate size of p, the proportion of nonconforming units of the production process.

It is easy to see that T_0 , the number of units inspected to obtain the first nonconforming, has a geometric distribution given by

$$P\{T_0 = n\} = q^{n-1}p, n \ge 1, \tag{5.1}$$

having tail probability

$$P(T_0 > n) = q^n, (5.2)$$

and mean waiting time

$$E(T_0) = \frac{1}{p}. (5.3)$$

Suppose we are only interested to detect the upward shift of p, i.e, we are only concerned with quality deterioration, then the resulting control chart has only the lower control limit (LCL). A small value of T_0 indicates that the nonconforming units have occurred too often for a process that is under control. The control procedure for this scheme is to send an out-of-control signal if the value of T_0 falls below the LCL. We require the probability of this to happen to be very small, say α , when the process is in control. In other words, α is the false alarm probability which is also the Type I error.

Let L_0 be the lower control limit for the CCC control chart with a given α , then

$$q^{L_0} = (1 - \alpha)$$
, i.e., $q^{L_0 + 1} - (1 - \alpha)q = 0$. (5.4)

It follows from (5.1) that

$$L_0 = \frac{\log(1-\alpha)}{\log q}. (5.5)$$

5.2 Modified CCC Control Chart Based on T

It is obvious from (2.1) that

$$P\{T > n\} = \frac{q^{n+1} - p^{n+1}}{q - p}.$$
(5.6)

It seems reasonable to propose a new control scheme based on the statistic T which is the waiting time for the appearance of a nonconforming unit preceded by one or more conforming units. T may also be interpreted as the total number of items that have been inspected during the time interval at each end of which a point is plotted on the control chart. Assuming we are concerned only with quality deterioration, we shall let L designate the lower control limit of the proposed chart satisfying

$$P(T > L) = \frac{q^{L+1} - p^{L+1}}{q - p} = 1 - \alpha.$$
 (5.7)

Equivalently,

$$q^{L+1} = p^{L+1} + (q-p)(1-\alpha), \tag{5.8}$$

where α is the probability of false alarm or the Type I error with the fraction nonconforming at some acceptable level $p = p_0$.

Unlike L_0 in Section 5.1, it is not easy to solve the above functional equation for L. However, the following observations would be helpful in our search.

First, by comparing (2.1) with (5.1), it is clear that

$$P\{T=n\} > P\{T_0=n\}, \text{ for } n \ge 2.$$
 (5.9)

(We note also that $P\{T=1\}=0$ whereas $P\{T_0=1\}=p$).

Equation (5.9) suggests that T would have a longer tail probability than that of T_0 . As a matter of fact, for any given n, the difference between the two tail probabilities (see (5.6) and (5.2)) is:

$$\frac{q^{n+1} - p^{n+1}}{q - p} - q^n = \frac{p(q^n - p^n)}{q - p} > 0, \text{ if } q > p,$$
(5.10)

and so $L \ge L_0$. Indeed, L is near L_0 for small values of p. In fact, for these small values of p, we note from (5.9) that

$$q^{n+1} = (1-\alpha)(q-p) + p^{n+1} \approx (1-\alpha)(q-p), \quad 0$$

For this range of p, L may be approximated as

$$L+1 \approx \frac{\log(1-\alpha)}{\log q} + \frac{\log(q-p)}{\log q}.$$
 (5.12)

In other words,

$$L \approx L_0 + \left\{ \frac{\log(q - p)}{\log q} - 1 \right\}, 0 (5.13)$$

A simple spread sheet can be used to find L. The following table gives the lower control limits of the modified CCC control chart when $\alpha = 0.025$ and $\alpha = 0.05$:

Table 1:Lower Control Limits For the Control Charts Based on T

p	L for $\alpha = 0.025$	L for $\alpha = 0.05$
0.01	3	6
0.005	6	12
0.001	26	52
0.0005	51	103
0.0001	254	513

With this new control scheme, the quality inspector would not take action (such as plotting a point on the chart) when two or more nonconforming units occur consecutively. This is perhaps the main difference between this new control chart and the existing CCC control chart that is based on the statistic T_0 . Psychologically speaking, one may regard the phenomenon of observing consecutive nonconformings as a fluke because of p being rather small. Looking from another angle, T can be interpreted as a 'delayed' version of T_0 .

For illustration, suppose a sequence of items from a production line have been inspected for quality having the acceptable quality level set at p = 0.01 and $\alpha = 0.05$ The result of this inspection process is as follows:

FFFFFFF<u>S</u>SSFFFFFF<u>S</u>FF<u>S</u>

Three points are then plotted on the control chart with $T_1 = 8$, $T_2 = 10$, and $T_3 = 3$. From Table 1 above, we find that the lower control limit L is 6. Since T_3 falls below L, an out-of-control signal is sent immediately so an action to examine the production line is called for. The result of the examination may indicate that the process is still operating properly; in that case, we would declare this out-of-control signal as a false alarm.

5.3 Comparison of Two Mean Waiting Times

Recall,
$$E(T_0) = \frac{1}{p}$$
 and $E(T) = \frac{1}{pq}$; so $E(T) = \frac{E(T_0)}{q} > E(T_0)$.

Also,

$$E(T) = \frac{1}{pq} = \frac{1}{p} + \frac{1}{q} = E(T_0) + \frac{1}{q}.$$
 (5.14)

Consider a Bernoulli sequence SSSFFFSSS where S denotes that E has occurred at that trial. Clearly, T is the number of trials required to obtain the first F plus the number of trials to obtain the first S (counting from the second F). We note that the forward recurrence time to an S in an independent Bernolli sequence is also a geometric random variable; just like the forward recurrence time for a Poisson event is also exponentially distributed. Therefore,

$$T = \text{Geometric}(q) + T_0. \tag{5.15}$$

So, (5.14) is a natural consequence of (5.15). Furthermore, (2.2) and (2.7) become a simple consequence of (5.15).

Assume that $E(T_0) = \frac{1}{p_0}$, we want to find value of p so that

$$E(T_0) = \frac{1}{p_0} = E(T) = \frac{1}{p(1-p)}.$$
(5.16)

Equivalently, we have

$$p(1-p) = p_0$$
 i.e., $p^2 - p + p_0 = 0$. (5.17)

Solving the quadratic equation for p, we obtain

$$p = \frac{1 \pm \sqrt{1 - 4p_0}}{2}. ag{5.18}$$

In the context of quality control, both p_0 and p are much smaller than 0.5, so (5.18) has only one meaningful root giving

$$p = \frac{1 - \sqrt{1 - 4p_0}}{2}. ag{5.19}$$

6. Average Number Inspected (ANI)

In order to evaluate the performance of a control chart, a measure such as the Average Run Length (*ARL*) is often used. Essentially, *ARL* is the average number of points that must be plotted before a point indicates an out-of-control condition. Bourke (1991) used the term *ANI* to refer to the expected number of items inspected until a signal is produced. This is equivalent to the definition given in Page (1954, p101) where *ARL* is defined as 'the expected number of articles sampled before action is taken'. In what follows, Bourke's (1991) terminology will be used.

6.1 ANI for CCC Control Chart

For the CCC control chart, the ANI is easy to obtain (Bourke (1991) and is given by

$$ANI(p) = \frac{1}{p} / P(Signal \mid p)$$
 6.1)

$$= \frac{1}{p} / P(T_0 \le L_0) = \frac{1}{p\alpha} , \qquad (6.2)$$

where α is the false alarm probability which is also the Type 1 error. Note that our aim here is to detect an upward shift of the process quality level p only. However, if both control limits are required, then $P(T_0 \le L_0)$ in (6.2) is to be replaced by $P(T_0 \le L) + P(T_0 \ge U)$ with $P(T_0 \le L \mid p = p_a) \le \alpha / 2$ and $P(T_0 \ge U \mid p = p_a) \le \alpha / 2$. Here p_a is the acceptable quality level, that is, the process is assumed to be in control at this level.

We note in passing that (6.2) may be derived by using the approach to be developed in the following subsection.

6.2. ANI for the Modified CC Control Chart:

Let N be the number of nonconforming units onserved that leads to an out-of-control signal and S_N be the total number inspected to obtain the first out-of-control signal. As N is a random variable so S_N is a compound random variable. N is effectively a stopping time random variable. Therefore,

$$E[S_N] = E[E(S_N)|N]$$

is the average number inspected in the sense of Bourke's (1991) terminology.

For given N = n,

$$S_n = T_1 + T_2 + \dots T_n$$

subject to $T_i > L$, i = 1, ..., n-1 and $T_n \le L$, where L is the lower control limit satisfying:

$$P(T \le L) = \alpha$$
.

Now,

$$E[S_N] = \sum_{n=1}^{\infty} E(S_n | T_i > L, 1 \le i \le n-1, T_n \le L) p_n, \ p_n = P(N = i) \ . \tag{6.3}$$

For given N = n, we can show that

$$E(S_n) = (n-1)\mu^+ + \mu^-, \tag{6.4}$$

where

$$\mu^+ = E\big[T \mid T > L\big], \ \mu^- = E\big[T \mid T \leq L\big].$$

(Recall, $T = T_1$, and T_i are independent and identically distributed).

We also note that N has a geometric distribution having mean $\frac{1}{\alpha}$.

It is well known (in fact it can be shown easily) that

$$\sum_{i=m}^{i=n} iq^{i-1} = \frac{mq^{m-1} - (m-1)q^m - (n+1)q^n + nq^{n+1}}{p^2}$$
(6.5)

Hence,

$$\mu^{+} = \frac{1}{(1-\alpha)(q-p)} \sum_{L+1}^{\infty} n \left\{ pq^{n} - qp^{n} \right\}$$

$$= \frac{1}{(1-\alpha)(q-p)} \left[\frac{q}{p} \left\{ (L+1)q^{L} - Lq^{L+1} \right\} - \frac{p}{q} \left\{ (L+1)p^{L} - Lp^{L+1} \right\} \right]$$

$$= \frac{1}{(1-\alpha)(q-p)} \left[\frac{(L+1)\left\{ q^{L+2} - p^{L+2} \right\} - L\left\{ q^{L+3} - p^{L+3} \right\}}{(q-p)} \right]$$
(6.6)

and

$$\mu^{-} = \frac{1}{(q-p)\alpha} \sum_{n=2}^{L} n \left(pq^{n} - qp^{n} \right)$$

$$= \frac{1}{(q-p)\alpha} \left\{ \frac{2q^{2} - q^{3} - (L+1)q^{L+1} + Lq^{L+2}}{p} - \frac{2p^{2} - p^{3} - (L+1)p^{L+1} + Lp^{L+2}}{q} \right\}$$

$$= \frac{1}{\alpha(q-p)} \left\{ \frac{2(q^{3} - p^{3}) - (q^{4} - p^{4}) - (L+1)\left\{q^{L+2} - p^{L+2}\right\} + L\left\{q^{L+3} - p^{L+3}\right\}}{pq} \right\}$$
(6.7)

It follows from (6.3) and (6.4) that the avearge number inspected for the control chart under discussion is

$$ANI = E[S_N] = \{EN - 1\} \mu^+ + \mu^-, \tag{6.8}$$

bearing in mind that $EN = \frac{1}{\alpha}$

It follows from (6.6)-(6.8) that

$$ANI = \frac{(2q^3 - 2p^3) - (q^4 - p^4)}{\alpha p q (q - p)}$$

$$= \frac{(2q^3 - 2p^3) - (q^2 + p^2)(q - p)}{\alpha p q (q - p)}$$

$$= \frac{(q^3 - p^3 + pq^2 - qp^2)}{\alpha p q (q - p)}$$

$$= \frac{1}{\alpha} \times \frac{1}{pq} = E(T)EN, \tag{6.9}$$

which is the Wald's identity in sequential analysis.

Comparing the two *ANIs*, we find that the *ANI* for the modified *CCC* scheme exceeds the *ANI* for the *CCC* control chart by the amount $1/(\alpha q)$. For a process that is in control, a control scheme that gives a larger *ANI* has an advantage as it would send fewer false alarm signals. However, for a high quality production process (i.e., for very small p, and hence for large q), this advantage becomes minimal. As we remarked in Section 5.1, the *CCC* control chart is also applicable for controlling fraction nonconforming even in the case when p is of moderate size. For such processes, the modified *CCC* control chart may be considered as a serious alternative.

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References

- Bourke, P. D. (1991). Detecting a Shift in Fraction Nonconforming Using Run-Length Control Charts with 100% Inspection, *Journal of Quality Technology*, Vol 23(3), pp.225-238
- Feller, W. (1968). Introduction to Probability Theory and Its Applications, Volume 1, Third Edition, Wiley International.
- 3. Goh, T. N. (1987). A Control Chart for Very High Yield Processes, *Quality Assurance*, Vol 13, pp.18-22.
- 4. Hunter, J. J. (1983). *Mathematical Techniques of Applied Probability*, Volume 1, Discrete Time Models: Basic Theory, Academic Press, New York.
- Hombas, V. C. (1997). Waiting Time and Expected Waiting Time- Paradoxical Situations, The American Statistician, Vol 51 (No 2), pp130-133.

- 6. Lucas, J. M. (1989). Control Scheme for Low Count Levels, *Journal of Quality Technology*, Vol 21, pp.199-201.
- 7. Nelson, L.S. (1994). A Control Chart for Parts-Per-Million Nonconforming Items, *Journal of Quality Technology*, Vol 26(3), pp.239-240.
- 8. Page, E. S. (1954). Continuous Inspection Schemes, *Biometrika*, Vol 41, pp.100-114.
- 9. Quesenberry, C. P. (1995). Geometric Q Charts for High Quality Processes, Journal of Quality Technology, Vol 27(4), pp.304-315.
- Wang, Y. H. and S. Ji (1995). Limit Theorems for the Number of Occurrences of Consecutive k Successes in n Markov Bernoulli Trials, Journal of Applied Probability, Vol 32, pp.727-735.
- 11. Xie, M. and Goh, T..N. (1992). Some Procedures for Decision Making in High-Yield Processes, *Quality and Reliability Engineering International*, Vol 8, pp.355-360.

















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